Notice of References Cited

Application/Control No. 10/594,077 Examiner	Applicant(s)/Patent Under Reexamination LEITGEB ET AL.		
Examiner	Art Unit		
Andrew C. Lee	2419	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,161,925	01-2007	Wallenius et al.	370/338
*	В	US-2006/0085823	04-2006	Bell et al.	725/081
*	С	US-2007/0123284	05-2007	Schliwa-Bertling et al.	455/518
*	D	US-7,107,017	09-2006	Koskelainen et al.	455/90.2
*	Е	US-7,408,948	08-2008	Lopponen et al.	370/433
*	F	US-6,928,294	08-2005	Maggenti et al.	455/518
*	G	US-2004/0196826	10-2004	Bao et al.	370/352
*	Н	US-7,170,863	01-2007	Denman et al.	370/260
*	Т	US-2003/0016632	01-2003	Refai et al.	370/260
*	J	US-7,146,181	12-2006	Schaedler et al.	455/466
*	к	US-6,671,513	12-2003	Frank et al.	455/456.1
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	ø					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

NON-FATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	v				
	w				
	×				

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.